

Search Notes

Application/Control No.

10/534,237

Examiner

Joseph Martinez

Applicant(s)/Patent under
Reexamination

TEIJIDO ET AL.

Art Unit

2873

SEARCHED

Class	Subclass	Date	Examiner
359	497, 629	11/21/2007	JPM
349	62	11/21/2007	JPM
385	31	11/21/2007	JPM
362	553, 555	11/21/2007	JPM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
reviewed related app: PCT/EP03/12417; re X- and Y- references	11/21/2007	JPM
see EAST text search attached: 359/497, 501, 629; 349/62; 385/27, 31, 39, 43, 52; 362/553, 555	11/21/2007	JPM
see EAST search attached: USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	11/21/2007	JPM